A Complete Bibliography of Publications in *Technometrics* for the decade 2010–2019

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#9 [Jen11].

$100.00 [Mar19a]. 2^{k-p} [LL16]. 3 [CG16, MQ11, VGS19, ZQ18, ZZD+14]. **$46.36** [Mar19a]. $C[0,1]$ [BLK19]. C_p [CHS11]. D [ZDH14, LMW19]. G [HN18]. I_λ [HN18]. k [Wył10]. N [RB10]. P [AGV12].

-D [MQ11]. **-Exploring** [CCCC13]. **-Optimal** [HN18, LMW19, ZDH14]. **-Optimality** [HN18]. **-QPSO** [LMW19]. **-sample** [Wył10]. **-Splines** [AGV12]. **-Valued** [BLK19].

1 [CZ15a]. **10.1007** [Ahm19b]. **10.1007/978** [Ahm19b]. **10.1007/978-3-319-91385-8** [Ahm19b]. **11th** [Ano11u]. **1st** [Sau10, Sau11, Sau12].

2009 [Cob10]. **2014** [Ano16a]. **2015** [Ano16c]. **2016** [Ano16k, Ano17a, Ano17b]. **2017** [Ano17i]. **2018** [Ano18g]. **2nd** [Ahm19b, Ano10s, Ano10g, Ano10n, Ano10o, Ano10i, Ano10l, Ano11d, Ano11p, Ano11h, Ano11j, Ano11i, Ano11c, Ano11k, Ano12n, Ano12i, Ano12c, Ano12d, Ano12p, Ano12o, Guo19, Jar12b, Oli11a, Pfa12, Qia10b, Qu12, Rut12, San11].

33rd [Ano11u]. **39** [Hor11b]. **3rd** [Ano12e, Ano12q, Hly11, Mar19b, Ors19].

4th [Ano10r, Ano11g].

5th [Ano12h].

6 [Mar19a].

8 [Ahm19b].

978 [Mar19a]. **978-1-4987-7606-6** [Mar19a]. **978-3-319-91384-1** [Ahm19b]. **978-3-319-91385-8** [Ahm19b, Ahm19b].

Abdelmomem [Ano12h]. **Aberration** [RB10]. **Accelerated** [LHTD18, Liu12, TL16, XKHY18]. **Accelerating** [NHQ17]. **Acceptance** [LRL+12b, LRL+12a]. **Accessibility** [CS12, DF12, JSQ12, JS12a, JS12b, LW12, WSZ12]. **Accomplish** [Nat12]. **Account** [DLY+17]. **Accumulated** [YZW19]. **Accuracy** [XQW13]. **Accurate** [PT14]. **across** [CCCC13]. **Activity** [ZHOY13]. **Actuarial** [Mye11b]. **Adaptive** [Che11a, KKS+14, LMS15, RMZ15, SWF16, TH18, XWL18, Gol12a]. **Addendum** [Got10b, Got10a]. **Additive** [AGV12, DLLR17, PH16, SHD18]. **Additivity** [Fra19]. **Adjustment** [JY15]. **Adjustments** [CJ14]. **Admissible** [WMT12]. **ADMM** [GFK+18]. **Adrian** [Fot10b, Hor11a]. **Advanced** [Hor10b, Hor10a]. **Advances** [Ano12j, Gra13, Ano10d, Ano10e, Lip19a]. **Aeilko** [Ano10r]. **Afifi** [Ano12h]. **AG** [Ahm19b]. **Aggregate** [CY17, SWW+18]. **Aggregated** [DGS13]. **Aggregation** [SWW+18]. **Agreement** [SAC17]. **Aitken** [Bur11]. **Akinori** [Ano10j]. **al** [Han10]. **al.** [CL16]. **Alain** [Bai11]. **Alan** [Bar11, Bur12]. **Albrecht** [AA12]. **Alex** [Ano12r]. **Alexander** [Mye11c]. **Alexey** [Mye11c]. **Algebraic** [Hor11b, Ano10f]. **Algorithm** [CG16, cCOP+13, DASS17, LKS16, NHQ17, XDHQ16, XC10]. **Algorithmic** [Qiu12]. **Algorithms** [Par11, SdCR12]. **Aliasing** [JN11]. **Aliev** [Sen11]. **Alignment** [SRZ+19]. **All-in-One** [HRV19]. **Allan** [San11]. **Allison** [Bar11]. **Allocation** [LCAc13, SNM10, TL16]. **Allowing** [HRV19]. **Almost** [GACH10]. **Almost-Parallel** [GACH10]. **Almost-Series** [GACH10]. **Along** [LM15]. **Alpaydin** [Ano10l]. **Alternative** [PJW13]. **Alternatives** [KSB16]. **Ambiguity** [WC12]. **Ameliorated** [ZX17]. **Analyses** [LPVW13, Pfa12].

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Averaging [Fra19, RKE10]. **Award** [Ano13b, Ano14a, Cho11, Cho12, Mit10, Ano16k, Ano16a, Ano16c, Ano17i, Ano17b, Ano18g, Bre13, Bre14b, Hla15].

B [Ano12i, Fot10b, Fot10a, Hor11e, Li10, Yu12, YCZ17]. **B-Splines** [YCZ17]. **Babatunde** [Cin11]. **Background** [YPS17]. **Baddeley** [Fot10b]. **Bai** [Ano12n]. **Bailer** [Ng12]. **Bailey** [Neu10a]. **Balakrishnan** [Ano10e]. **Balanced** [Hof10]. **Band** [TMAZ18]. **Bank** [LVB13]. **Banking** [Han10]. **Baragona** [Cha12]. **Barnett** [Hor11a, Mye12a]. **Basawa** [Ano11l]. **Based** [cCOP$^+$13, CY17, CWW17, CGB$^+$14, DASS17, FPG19, LC15, GLLS14, HLP13, HM10, HM13, HQH16, JN17, JK11, Jos12a, LZ15, Liu12, LACR11, MDS12, PGRC13a, SAH$^+$17, SG18, SCH17, XDHQ16, YXTS12, ZZD$^+$14, ZJT11, KMM11]. **Basic** [Jen10]. **Basis** [CBD$^+$17, SWMW13]. **Basu** [Ano11m]. **Batch** [DASS17]. **Battaglia** [Cha12]. **Bayes** [LPVW13]. **Bayesian** [Ano11f, Ban10b, Bur11, Gru11, Hey12, Lip19f, Apl12, AHS16, BWMG14, CMR10, Car14, CGR$^+$15, CWW17, DNV16, EDR16, FK14, Fra19, GB18, GW13, GWN13, HN12, HS14, HLSR15, HP12, Jos12a, KRSA15, KKS$^+$14, LHTD18, LG13, LHDP14, LKS16, MMEDG14, MBR14, OW17, PD11, PHK$^+$18, PH16, PR17, SHD18, TS12, TW13, TH10, WC12, WLWZ16, YZW19, ZCM$^+$18, Ban11, Bar10, Boo10a, Che11a, Guo19, Li10, Lip12a, Mag11]. **Bayesian/Likelihood** [Bur11]. **Becker** [Han10]. **Beginner** [Ano12c, Bai11]. **Behaved** [LMW19]. **Behavior** [QX14, TMAZ18]. **Behavioural** [Ahm19c]. **Belief** [Lip19f]. **Benefits** [EJLN17]. **Berger** [Ano11f]. **Bernd** [Hor11b]. **Bernhard** [Ano10g]. **Bernstein** [Tan16]. **Berry** [Che11a]. **Best** [LCAc13]. **Bettencourt** [WMI11]. **Between** [FQ18, QWKR14]. **Bhat** [Hly10a]. **Bhatia** [Lu11]. **Bias** [Gol11a]. **Bidirectional** [QL19]. **Biennial** [Ano11u]. **Bifocal** [WC12]. **Big** [ILS$^+$17, LKS16, Qiu16a, SWW$^+$16, XWL18, ZY17]. **Biggeri** [Ano10m]. **Binary** [DSM13, LMW19]. **Bini** [Ano10p]. **Binomial** [CMAC12, Qu12]. **Bioconductor** [Ano12o]. **Bioinformatics** [Ano10d]. **Biological** [FD15, ZZZ$^+$15, Ano10h]. **Biology** [Ano12p, Hor11a]. **Biomedical** [Che12b, SHL15]. **Biostatistics** [Boo10a]. **Biosurveillance** [SB10]. **Birnbaum** [ZLD16]. **Bissett** [Ke10]. **Bit** [ZHOY13]. **Biweight** [CRW18]. **Black** [MW19]. **Black-Box** [MW19]. **Blackbox** [CW16, CL16, GGL$^+$16a]. **Blackjack** [Ahm19b]. **Blending** [BDB15]. **Blind** [KMQ18]. **Block** [Bag10, Mic10]. **Blocked** [MGJ14, Wv11]. **Blocking** [JN16, SSG15]. **Blurred** [KQ14]. **Board** [Ano12b, Ano13j, Ano14h, Ano15e, Ano16i, Ano17h]. **Boca** [Mar19a]. **Bocard** [Mye12c]. **Bock** [Ano10j]. **Boelen** [Bar10]. **Book** [AA12, Ahm19a, Ahm10, Ahm19b, And11, Ano10s, Ano10g, Ano10j, Ano10r, Ano10h, Ano10n, Ano10q, Ano10p, Ano10t, Ano10k, Ano10o, Ano10d, Ano10e, Ano10f, Ano10i, Ano10m, Ano10l, Ano10u, Ano10v, Ano10w, Ano10x, Ano11d, Ano11o, Ano11p, Ano11h, Ano11n, Ano11f, Ano11g, Ano11l, Ano11e, Ano11j, Ano11m, Ano11i, Ano11c, Ano11k, Ano11q, Ano11r, Ano11s, Ano11t, Ano12h, Ano12n, Ano12f, Ano12j, Ano12e, Ano12i, Ano12c, Ano12g,

Ano12k, Ano12d, Ano12q, Ano12p, Ano12o, Ano12l, Ano12r, Ano12m, Ano12s, Ano12t, Ano12u, Ano12v, Ano13c, Ano13d, Ano13e, Ano13f, Ano14b, Ano14c, Ano14d, Ano14e, Ano15d, Ano15a, Ano15b, Ano15c, Ano16d, Ano16e, Ano16f, Ano16g, Ano17f, Ano17c, Ano17d, Ano17e, Ano18a, Ano18b]. **Book** [Ano18c, Atk12, Bai11, Bai12, Ban10b, Ban10a, Ban11, Bar10, Bar11, Bha12, Boo10b, Boo10a, Bur10, BL11, Bur11, Bur12, Bzi11, Cha11, Cha12, Che11c, Che11a, Che11b, Che12a, Che12b, Cin11, Cob10, Esp11, Fot10b, Fot10a, Fre12, Gho10b, Gho10a, Gho11a, Gho11b, Gho12a, Gho12b, Gho19, Gol11b, Gol11a, Gol12c, Gol12b, Gol12a, Gru11, Guo19, Hec10, Hec11, Hey12, Hin11, Hly10a, Hly10b, Hly11, Hly12, Hor10b, Hor10d, Hor10c, Hor10a, Hor11f, Hor11d, Hor11b, Hor11c, Hor11a, Hor11e, Hor12c, Hor12b, Hor12d, Hor12a, Jar12b, Jar12a, Jen10, Jen11, Kat11, Ke10, Ke11a, Kuh10, Laz10, Laz11, Li10, Lip10a, Lip10b, Lip11a, Lip11c, Lip11b, Lip12b, Lip12d, Lip12c, Lip12a, Lip19a, Lip19b, Lip19c, Lip19d, Lip19f]. **Book** [Lip19e, Lu11, Mag11, Mai11, Mar19a, Mar19b, McC10, McC12b, McC12c, McC12a, Mic10, Mye11a, Mye11b, Mye11c, Mye12a, Mye12c, Mye12b, Mye12d, Nat12, Neu10b, Neu10a, Neu11, Neu12c, Neu12b, Neu12a, Ng10, Ng11, Ng12, Nku10, Oli10a, Oli10c, Oli10b, Oli11b, Oli11a, Oli12c, Oli12a, Oli12b, Ors19, Par11, Pen10, Pfa12, Qia10b, Qia10a, Qiu12, Qu11, Qu12, Ros11, Rut12, San11, Sar11, Sau10, Sau11, Sau12, Sea11a, Sea11b, Sea12, Sen11, SB19, Sym11, Van10, Wie11, WMI11, Wlu12, Ye10, You10, Yu12]. **Bootstrap** [AGMRS11, LKS16]. **Both** [DLY+17, HLLY16]. **Boundary** [Tan18]. **Bounded** [DSD12]. **Bounds** [Lu11]. **Box** [MW19, Hun13, ZY17]. **Bradley** [Atk12, Che11a]. **Brajendra** [Gol12c]. **Brenda** [Sar11]. **Bretz** [Che11b]. **Brian** [Ke10, Pfa12]. **Bridge** [JSMS15]. **Brockhoff** [Hor11e]. **Broemeling** [Boo10a]. **Brooks** [Che12a]. **Brownian** [PA17, TQW13]. **Bruce** [Laz11]. **Bruggemann** [Lip12b]. **Bug** [SDR15]. **Bug-Database** [SDR15]. **Building** [PT14, SHD18]. **Burgess** [Hor12c]. **Burkholder** [Hor12c]. **Burn** [YXTS12]. **Burn-In** [YXTS12]. **Business** [Mye12a, Neu10b, Wlu12, McC12a]. **Byleen** [Mye12a].

C [Ano10s, Ano10t, Ano11l, Ano12e, Ban10a, Gol12c, Wie11]. **Calibration** [CBBJ18, CJ14, EPD18, GBH+13, HGL+13, JY15, OY17, PSB+13, PH16]. **CALL** [Ano13h]. **Campaign** [ZCW19]. **Capture** [KKS+14]. **Capturing** [SHD18]. **Carbon** [KKS+14, SRZ+19]. **Care** [Ban10a]. **Carlin** [Che11a]. **Carlo** [Ano10n, Ano11e, Mar19b, Neu11, Ng10, SH14, Che12a]. **Carlos** [WMI11]. **Carol** [Ano10e]. **Case** [Atk12, Cob10, LD11, LCAc13, PFF14, RMZ15]. **Case-Deletion** [PFF14]. **Casella** [Neu11, Ye10]. **Casino** [Ahm19b]. **Castillo** [WMI11]. **Castillo-Chavez** [WMI11]. **Castle** [Hor10d]. **Catalyst** [Fre13]. **Categorical** [Gho19, PGS11]. **Catherine** [Ano10e]. **Causality** [Ano10i]. **Causation** [Gol11a]. **Cell** [Zha11]. **Cells** [RV18]. **Cellwise** [HRV19]. **Censored** [CBBJ18, RZ16, ZYH14, WYJ10]. **Censoring** [EW10, GLLS14, KMM11]. **Central** [MM19, SGH13]. **Centric** [Lip19b].

certain [WYJ10]. **Chain** [Che12a]. **Chains** [AHS16, CMR10, Hly10b]. **Challenges** [Qiu16a, SB10]. **Cham** [Ahm19b]. **Chambers** [Oli10c]. **Chan** [Qia10b]. **Chang** [Hor10c]. **Change** [AG12, HN12, Lip19e, PZQ16, WB18]. **Change-Point** [HN12, PZQ16]. **Changepoint** [BFE+19]. **Changepoints** [AHS16, NAEK15]. **Changes** [NAEK15, RTA11]. **Chaoqun** [Par11]. **Characteristic** [Gho10a]. **Characteristics** [XTP17]. **Characterizing** [SFH+13]. **Charles** [Nat12]. **Chart** [BJFB14, CM11, CZZ16, JFEH14, SD12, ZT11]. **Charts** [Apl12, QWKR14]. **Chavez** [WMI11]. **Chemometrics** [Lip10b]. **Chen** [Ano10h, Ano11f]. **Chin** [Gol12a]. **Choice** [WND+18]. **Chow** [Gol12b]. **Chowell** [WMI11]. **Christian** [Neu11]. **Christiane** [Ng10]. **Christman** [Hor11f]. **Christopher** [Gho12b]. **Christos** [Ano10d]. **Chung** [Gol12b]. **Civil** [HLSR15]. **Cizek** [Jar12b]. **Claims** [LCL12]. **Clarification** [Ano18e]. **Clarifications** [HS17]. **Clark** [Cob10, Ano12h]. **Class** [DNV16, TL16]. **Classes** [DNV16]. **Classification** [Ano10j, Ano11u, GJL15, KRSA15, WZ19, Ano11e]. **Classifications** [dMvW10]. **Classifiers** [QL19]. **Claus** [Ano11u, Neu12c]. **Clear** [Grö14, WMT12]. **Cleophas** [Ano10r, Ano10r]. **Clinical** [Ano10r, Ano11g, Che11a, Gol12b, Gol12a, And11]. **Cloud** [YPP19]. **Cluster** [WSZ14]. **Clustering** [cCOP+13, CS12, DF12, Far14, HCT17, JSQ12, JS12a, JS12b, KMQ18, KRSA15, LW12, Par11, TMAZ18, WSZ12, ZZD+14, Hor11d]. **Coastal** [AGRI19]. **Codes** [LC15, RBM08, XQW13, RBM11]. **Coefficient** [GAZ15, KL17]. **Cointegrated** [Ano10g]. **Cokriging** [LC15]. **Cokriging-Based** [LC15]. **Cold** [RKE10]. **Collaborators** [Ano10y, Ano11v, Ano12w, Ano13g, Ano14g, Ano16h, Ano17g, Ano18d, Ano19b]. **Collection** [ZTEM17]. **Colorimetric** [ZS15]. **Column** [LL16, Qu10]. **Combination** [HS14]. **Comment** [ACH14, Apl10, Bor12, Bre14a, CW16, CL16, CMS10, CS12, DM12, Dav13, DF12, For13, Fre13, GJ10, Gra13, HWL16, JSQ12, Jon13, Jos12b, Kle13, Lee12, LW12, LZ14, LS13, O'C10, OW12, PGK16, Pie13, PJW13, Ran13, SWWR14, SF10, Sin10, SJ12, Tsu10, TQW13, WSZ12, WAC10, WBD10]. **Common** [ZY18]. **Communication** [PGS11, Cha11]. **Community** [GWN13]. **Companion** [Sea11a]. **Comparative** [Ano11j, Lip12a, Neu10a]. **Comparing** [HG11, KSB16, SAC17, SFH+13, Gho11a]. **Comparison** [Bor12, CMAC12, Gru11, LM13]. **Comparisons** [Che11b, Gol11a]. **Competing** [SS15, SNM10, YXTS12]. **Complete** [Lip19d]. **Complex** [HNKF18, JDTW15, Kat11, LAMO+16, Lip11a, Lip19f, PH16, RBM08, RBM11, Ano12f]. **Complex-Valued** [HNKF18]. **Compliance** [LRL+12b, LRL+12a]. **Component** [CFF13, MGJ14, WMP18, ZTEM17, ZW17]. **Composite** [GLLS14, MM19, Nat12]. **Comprehensive** [Van10]. **Compressing** [CG16]. **Compromise** [Jon13]. **Computation** [Got10b, Got10a, HN18, Jos12a, Lip19b, NHQ17, Sea11b, You10]. **Computational** [Che11c, Neu12b, Oli10a, Boo10b, Hin11, Lip10a]. **Computationally** [Ano12f, CMAC12, FNL11, RHK11]. **Computer**

[BGMA14, DLLR17, DP10, Dri10, EPD18, FK14, GBH+13, GL12, LC15, HS14, HTW17, HGL+13, HLLY16, HJM15, JLLM+16, JDLH16, JK11, KAT18, LZ16, MDS12, Mor12, Mor15, OY17, PGRC13a, PSB+13, PH16, RBM08, RHK11, Ran13, She17, Tan15a, Tan15b, Tan17, TWY14, VSM13, XQW13, ZQZ11, RBM11]. **Computing** [HS16, HS17]. **Concatenation** [VGS19]. **Concepts** [Jen10, Lip19b]. **Conceptual** [Oli10a]. **Concerns** [LS13]. **Concise** [Neu12a]. **Condition** [KZS+18]. **Conditional** [CM14]. **Conditions** [Tan18]. **Conference** [Ano11u, CCCC13]. **Confidence** [Ruk15, WLHB15]. **Conjugate** [SL18]. **Connected** [Lip11b]. **Connection** [MZ13]. **Connectivity** [ZCG+16]. **Consistent** [FP17]. **Constable** [Rut12]. **Constrained** [CW16, CL16, Far14, GGL+16a]. **Constraints** [LZ14]. **Constructing** [MKBN19, SGS15, VGS19]. **Construction** [EJLN17, VX19]. **Consumer** [Hor11e]. **Contamination** [PD11]. **Continuous** [Ahm19c, CMR10, JFJ+19, LMW19, Qia10a, Sar11, SH14]. **Contour** [RBM08, RBM11]. **Control** [Ahm19d, BJFB14, CM11, CZZ16, Hor10c, Jen11, JFEH14, LQ14, QL11, QWKR14, SD12, TS12, XTP17, ZJT11, ZT11]. **Controller** [TML16, TC17]. **Controlling** [WH19]. **Controversial** [Gol12b]. **Convex** [HS14, QL19]. **Convolution** [KZS+18]. **Cook** [GAZ15]. **Cooper** [Ano10s]. **Cooperation** [Ano10j]. **Coordinate** [OW17, SAH+17, SdCR12]. **Coordinate-Descent-Based** [SAH+17]. **Copula** [XHX17, ZW17]. **Core** [Qu11]. **Correction** [Ano19c]. **Correlated** [HWL16, JP13, NS15, Wv11, Nku10]. **Correlation** [Pie13]. **Corrigendum** [Ano13i, Ano18f]. **Count** [STZW16]. **Counterfactual** [Lip19e]. **Counting** [XMM16]. **Course** [Ano11c, Hey12, San11, McC12b, Qu11]. **Covariance** [FOU13, HS16, HS17, LZ16, Zha11]. **Covariate** [HM13]. **Covariates** [HDM+15, HW10]. **Cox** [ZY17]. **CRC** [Mar19a]. **Crimes** [SNY+10]. **Criminology** [Ano12r]. **Criteria** [LRL+12b, LRL+12a, LACR11, Ran13]. **Criterion** [CRW18, CHS11, HN12, HTW17, SdCR12, TG10]. **Cross** [LC15, ZZD+14]. **Cross-Sectional** [ZZD+14]. **Cross-Validation** [LC15]. **Crowds** [Lip11b]. **Cryer** [Qia10b]. **Curt** [Ano11g]. **Curve** [QZZ18, ZDH14]. **Curves** [CS12, DF12, Gho10a, HSL+13, JSQ12, JS12a, JS12b, LW12, Qia10a, SFH+13, WSZ12]. **CUSUM** [CZ15a]. **Cusums** [LCL12]. **Cyber** [XHX17]. **Cylinder** [GGP10].

D [Ano11g, Ano12c, Bai12, Boo10a, Che12b, Fre12, Hey12, Mye12b, Nat12, Qia10b, CG16, MQ11, ZQ18, ZZD+14]. **Dale** [Ban11, Gho12a]. **Damage** [YZW19]. **Daniel** [Ano11i, Mye12c]. **Daphne** [Bha12]. **Darren** [Ano12p]. **DasGupta** [Ano11m, McC12b]. **Data** [Ano10j, Ano10h, Ano10d, Ano11o, Ano11u, Ano12f, Ano12j, Ano12g, Ano12o, Bai12, BFE+19, BJFB14, BDB15, Bur10, CBBJ18, CM11, CM17, CCCC13, CMAC12, cCOP+13, CY17, CRBM19, DGS13, Fre13, GJL15, Ger15, Gho19, GG12, Guo19, Hec11, HM13, HDM+15, Hor10b, Hor11a, HRSV16, HW10, ILS+17, JAP15, JDLH16, JFEH14, JP13, Ke10, Ke11a, Kuh10, LG13, LKS16, LSP13, Lip12a, Lip19b, LCAc13, Mar11, Mar19a, MGSC18, MLBM19, MBR14, NKCB14, Nku10,

Oli10c, Oli12a, Par14, PHK+18, Pen15, Qiu16a, RHK11, RMVH11, RTA11, RV18, SHD18, Sar11, SWW+16, STZW16, SAR16, SZ19, Sym11, WX10, WYHT18, Wył10, XWL18, XKHY18, XHM+17, YPS18, YPP19, YT16, ZQ18, ZLD16, ZY17, ZS15, ZYH14, ZCM+18, ZWZJ15, Ano10o, Che12b, Fre12, Gho11b, Gho12a, Gol12c, Kat11, Mai11, McC10, Qia10a, Ano11e]. **Data** [Par11, Sau10, Sau12]. **Data-Centric** [Lip19b]. **Data-driven** [Wył10]. **Data-Focused** [CCCC13]. **Database** [SDR15]. **Dataset** [BFK+12]. **Datasets** [GB18, KH19, NKCB14, ZHOY13]. **David** [Ano10t, Ano11g, Ano12e, Ano12q, Ano12r, Bai12, Hor10d, Lip11b, Pen10, Qia10a]. **Davis** [Hor12c, Hor12d]. **Debabrata** [Ano11m]. **Deblurring** [KMQ18]. **Deborah** [Ano10k]. **Decision** [Ano11f, Lip19f]. **Decision-Making** [Lip19f]. **Decisions** [Guo19]. **Decomposition** [HS19, LAMO+16, YPS17, YPS18, Oli12c]. **Deepayan** [Kuh10]. **Defect** [Sen11, SDR15]. **Defense** [XHX17]. **Definitive** [JN16, JN17]. **Degenerate** [ZZZ+15]. **Degradation** [Ano10e, HDM+15, Pen15, SYW19, TL16, WX10, WMEW13, VWGR11, XKHY18, YXTS12, YC14, ZY18, ZSGM14]. **Degradation-Based** [YXTS12]. **Degrees** [CHKC10]. **Deletion** [PFF14, RMZ15]. **DeMets** [Ano11g]. **Dempster** [Mye11a]. **Denoising** [MQ11]. **Densities** [TWY14]. **Density** [CGR+15, MGSC18]. **Department** [CCCC13]. **Dependence** [FP17, ZW17]. **Dependent** [GGP10, HRC10, LD11, Liu12]. **Depth** [HS19, TMAZ18]. **Derivative** [CHS11, HSL+13]. **Derived** [TW12]. **Descent** [SAH+17]. **Described** [CMR10]. **Design** [AA12, ANAC13, Atk12, BN12, BHGL19, DMW10, DP10, DASS17, EPD18, GJ19, LC15, JLLM+16, JN17, Jos12a, KJB11, KAT18, KKS+14, LHTD18, LZ15, MSE17, Mor15, MGJ14, OW17, PGS11, Pie13, PJW13, PHBF17, RBM08, SD15, Tad13, TW12, TW13, Tan13, Tan15a, XQW13, XDHQ16, ZDH14, RBM11, Ye10, Gol11b, Neu10a, Wie11]. **Design-Based** [JN17, XDHQ16]. **Designed** [LACR11]. **Designs** [ASDMLF16, ACH14, AG12, BMB15, CMAC12, CWW17, DSD12, DASS17, Edw11, ES17, EJLN17, GG12, Got10b, Got10a, Grö14, He19, HN18, HQH16, JN11, Jon13, JSMS15, JN16, JN17, JDTW15, JWG+19, JGBM19, LL16, LMZ19, LMW19, MM19, ME12, Oli10a, PCWW16, Qu10, RB10, SSG15, SGS15, SWWR14, She17, SdCR12, Tan13, TG15, TG17, TG10, VX19, VGS19, Wv11, WMT12, Mic10]. **Destination** [Car14, Haz10]. **Destructive** [XKHY18]. **Detecting** [RMZ15, RV18, ZZD+14]. **Detection** [AHS16, BFE+19, BVW10, BH13, FQ18, Fra19, GWN13, Han10, JFJ+19, KQ14, KRSA15, LMT14, NHB+13, SB10, Ste10b, TMMH17, WB18, YPS17, YZW12]. **Deteriorating** [YXTC14]. **Deterministic** [HS14, JWG+19, RHK11, Tan17]. **Development** [And11, Mor15]. **Deviating** [RV18]. **Deviation** [SHD18, SD12]. **Dey** [Ano11f]. **Diagnosis** [ILS+17, PZQ16]. **Diagnostic** [Boo10a, BA18, ZJT11]. **Diagnostics** [PFF14]. **Dieter** [AA12]. **Difference** [FQ18]. **Differences** [HCT17, HP12]. **Different** [MM19, TWY14]. **Differential** [LZW15, SCH17]. **Diggle** [Bur12]. **Digital** [Lip19c, Sen11]. **Dimension** [CSY18, MZ15, WX14, ZM19]. **Dimensional** [ANAC13, Ano12n, CGR+15, Dav13, DNV16, Fre13, GFK+18,

HRSV16, LS13, LMS15, Mar11, PTZ19, Pie13, PH16, SL18, WSZ14, YPS18, ZHOY13, ZLD16, ZWZJ15]. **Dimensions** [QLS+19]. **Dimitris** [Hor12d]. **Dipak** [Ano11f]. **Directional** [SWW+18]. **Dirichlet** [HRC10, WB18]. **Dirk** [Ano10n]. **Discovering** [SAR16]. **Discrete** [Ano12c, GJ10, HEM10a, HEM10b, Kle13, LMW19, MW19, O'C10, SF10, Sin10, WAC10]. **Discrete-Event** [Kle13]. **Discrete-Use** [GJ10, HEM10a, HEM10b, O'C10, SF10, Sin10, WAC10]. **Discriminant** [CHWE11, MZ13, ZM19, ZS15]. **Discrimination** [WZ19]. **Discussion** [Han10]. **Disease** [Hor11d, Li10]. **Disparate** [SHD18]. **Dispersion** [HL17, TL16]. **Distance** [CYZ17, GJL15, GAZ15, HS16, HS17, JK11, WZ19]. **Distributed** [AS16]. **Distribution** [AMY14, Apl12, BJFB14, CM17, CZZ16, CYZ17, HRC10, Oli12b, WW18, Zha10, ZTEM17]. **Distribution-Free** [BJFB14, CM17, CZZ16]. **Distributions** [BJFB14, CM14, DNV16, FNL11, KRSW19, WYJ10, Gho11a, Pen10]. **Dmytro** [Mye11c]. **Do** [DM12, Jos12b, Lee12, OW12, SJ12]. **Dobson** [Hor11a]. **Doganaksoy** [Neu10b]. **DOI** [Ahm19b]. **DoIt** [Jos12b, Lee12, OW12, Jos13, SJ12]. **Dolt** [DM12]. **Domenico** [Ano10p]. **Dominating** [Grö14]. **Donald** [Hor12c]. **Dongchu** [Ano11f]. **Down** [XTP17]. **Downscaling** [MKBN19]. **Dräghici** [Ano12o]. **Draief** [Lip11a]. **Driven** [JY15, Wył10]. **Drton** [Hor11b]. **Dudley** [Ano11n]. **Dudoit** [Ano12l]. **Durrett** [Laz10]. **Dynamic** [Ahm19d, AGMRS11, CJL14, Ger15, HM13, HDM+15, LQ14, PTZ19, QX14, QZZ18, RKE10, TML16, TC17, YR11, ZY18, Gol12c]. **Dziga** [Lip19c].

e-book [Ahm19b, Mar19a]. **Early** [SB10, XHX17]. **Early-Warning** [XHX17]. **Easley** [Lip11b]. **Ecology** [Hor12a, Mye12c, Oli10b]. **Econometric** [Ban11]. **Econometrics** [Hor10d]. **Economic** [Lip19f, McC10]. **Economics** [Mye12a]. **Economy** [Nat12]. **Ecosystems** [XMM16]. **ed** [Ahm19b, Ano10s, Ano10g, Ano10r, Ano10n, Ano10o, Ano10i, Ano10l, Ano11d, Ano11p, Ano11h, Ano11g, Ano11j, Ano11i, Ano11c, Ano11k, Ano12h, Ano12n, Ano12e, Ano12d, Ano12q, Guo19, Hly11, Jar12b, Mar19b, Oli11a, Ors19, Pfa12, Qia10b, Qu12, Rut12, San11, Sau10, Sau11, Sau12, Ano13j, Ano14h]. **Edition** [Ano12g, Ano12i, Ano12c, Ano12p, Ano12o]. **Editor** [Qiu15, ANAC14, Chi11, Chi12b, Chi13, Con10, Apl17, E19, Qiu14, Qiu16b, Ste10a]. **Editorial** [Ano10y, Ano11v, Ano12b, Ano12w, Ano13g, Ano14g, Ano15e, Ano16i, Ano16h, Ano17h, Ano17g, Ano18d, Ano19d, Ano19b, CJDN15, Chi12a, Edi15]. **Educational** [Ano10p]. **Edward** [Mye11b]. **Effect** [Bag10]. **Effective** [JN17]. **Effectiveness** [XHX17]. **Effects** [Apl10, CMS10, DLY+17, ES17, HL17, Hof10, Kat11, LRL+12b, LRL+12a, MGJ14, Oli10b, Pen15, QZW10a, QZW10b, SGC14, Tsu10, WBD10]. **Efficiency** [Ban10a]. **Efficient** [BGMA14, CMAC12, CW16, CSY18, EJLN17, FNL11, JN11, KMQ18, SH14, ZM19, ZWZJ15]. **Eigenvalues**

[Lu11]. **Ekstrøm** [Neu12c]. **Elastic** [SAH+17, WSZ14, ZLD16]. **Elastic-Net** [ZLD16]. **Electricity** [AGMRS11, CJL14]. **Electromagnetic** [JLLM+16]. **Electron** [CGR+15]. **Elementary** [Laz10]. **Elements** [Oli12b]. **Elena** [Bai11]. **Elliptical** [BJFB14]. **Emissivity** [BWMG14]. **Emmanuel** [Ano12d]. **Empirical** [PTZ19]. **Emulation** [CBD+17, OY17, WHQ18, YR11, ZQZ11]. **Emulations** [KAT18]. **Emulators** [FOU13, GL12, PT14]. **Enabled** [CM14]. **Encyclopedia** [Ahm10]. **Energy** [CCCC13, JDTW15, JWG+19]. **Engine** [GGP10]. **Engineering** [ANAC13, Dav13, JY15, Pie13, Gho10b]. **Engineering-Driven** [JY15]. **Engineers** [Bzi11, Cin11]. **Enhance** [JFEH14]. **Enhancements** [PGK16]. **Enhancing** [Jon13]. **Enough** [Bzi11]. **Ensemble** [CG16, HGL+13]. **Enterprise** [Rut12]. **Entry** [Far14]. **Entry-Wise** [Far14]. **Envelope** [ZL17]. **Envelopes** [CZ15b, CS16]. **Environmental** [Nat12]. **Environments** [ZY18]. **EOV** [Ano13j, Ano14h, Ano15e, Ano16i, Ano17h]. **EPIC** [LD11]. **Epidemics** [Lip11a]. **Epidemiology** [Li10, WMI11]. **EQIE** [HTW17]. **Equations** [LZW15, SCH17]. **Equivalence** [Ano11p, DNV16, MZ13]. **Era** [ILS+17]. **Eric** [Fre12, Laz11]. **Erik** [Bai11]. **Errata** [RBM11]. **Erratum** [Ano12x, Ano16j, LRL+12a]. **Error** [LG13, Ano10k]. **Errors** [ZCW19]. **Errors-in-Variables** [ZCW19]. **Estimate** [CSY18, ES17]. **Estimating** [GW13, LM15, Par14, SNM10, TBMM15, ZTEM17]. **Estimation** [Ahm19a, CGR+15, CHS11, CY17, CYZ17, JWFW19, LVB13, LZW15, LZHZ18, LCAc13, MGJ14, PBH13, RBM08, RZ16, SCH17, SGH13, SWF16, WC12, WMI11, YXTC14, Zha10, ZDH14, ZYH14, RBM11, Gru11, Ahm19a]. **Estimators** [AMY14, Ano11j, Wad16]. **Ethem** [Ano10l]. **Eugene** [Ano10r, Ano11l]. **Eva** [Ano10f, Fot10b]. **Evaluating** [dMvW10]. **Evaluation** [Ano10p, Bar10, CBC15, Guo19, LMT14, TMMH17]. **Evarist** [Ano11n]. **Event** [GLLS14, HW10, Kle13, LÇC12, QWKR14]. **Events** [RMVH11, WYHT18]. **Everitt** [Pfa12, Yu12]. **Evolution** [Ano12d]. **Evolutionary** [Cha12]. **EWMA** [TML16, ZT11]. **Ewout** [And11]. **Exact** [HN18, PSR17, WLHB15]. **Example** [Hly10b, Ke11b]. **Excel** [Ke10]. **Exchange** [OW17, SdCR12]. **Exchanges** [Ano10k]. **Excursion** [AGRI19, CGB+14]. **Expanded** [XC10]. **Expansions** [Gho12b]. **Expected** [CW16, For13, Gra13, WC12]. **Expectile** [YZZ18]. **Expensive** [FNL11, JWG+19]. **Experiment** [GLLS14, Mic10, RBM08, SD15, RBM11]. **Experimental** [AA12, ANAC13, ASDMLF16, Ano10k, CMAC12, GG12, GJ19, MM19, Mor15, Pie13, PJW13]. **Experimentation** [Fre13, Van10]. **Experiments** [AG12, Atk12, BN12, BHGL19, BGMA14, BDB15, DP10, EDR16, GL12, HS14, HTW17, HLLY16, HJM15, JLLM+16, JK11, Jos12a, JGBM19, KJB11, KAT18, LWM13, LACR11, MKBN19, MDS12, MGJ14, OW17, PGS11, PGRC13a, PHBF17, Qu10, She17, TW13, Tan15a, Tan15b, Tan17, TWY14, WB11, Wv11, dCC11, Neu10a]. **Experiments-Based** [Jos12a]. **Explanatory** [Pen15]. **Exploiting** [Wad16]. **Exploration** [BHGL19, cCOP+13, JDTW15]. **Exploratory** [Ano12g, Mar19a]. **Exploring** [Apl12, CCCC13]. **Exponential** [CJL14, TL16, ZDH14].

Exponential-Dispersion [TL16]. **Exponential-Linear** [ZDH14]. **Exposure** [JLLM+16]. **Extensions** [CZ15a, Oli10b]. **Extrema** [AGRI19]. **Extreme** [Wad16, Jar12a].

F [Ano10r, Bai11, Hly12, Hor10d, Oli10b]. **Fabrizio** [Ahm10]. **Facing** [SB10]. **Factor** [AGMRS11, AG12, Bag10, CJL14, ES17, Grö14, LMZ19, Tad13, WMT12, ZX17]. **Factorial** [DASS17, EDR16, Fra19, Grö14, LMZ19, RB10, SGS15, TG10, Van10, WMT12]. **Factorial-Based** [DASS17]. **Factorials** [HL17]. **Factorization** [DS17]. **Factors** [DLLR17, GJ19, LMW19, ZQZ11]. **Fahrmeir** [Ano10q]. **Failed** [WYHT18]. **Failed-But-Not-Reported** [WYHT18]. **Failure** [HM10, HM13, Liu12, SYW19, SNM10]. **Failure-Time** [HM13]. **Failures** [YT16]. **Faltin** [Ahm10]. **Familial** [Gol12c]. **Families** [HLP13]. **Farm** [PHD16]. **Fast** [CGB+14, EJLN17, Got10b, Got10a, LC15, HN18, HS16, HS17, PSB+13]. **Fault** [ILS+17]. **Feature** [Lip10a, PJR15]. **Federer** [Mic10]. **Fernandez** [Ano11o]. **Ferrari** [Ano10m]. **Ferraty** [Ano12j]. **Ferreira** [Ban10b]. **Festschrift** [Ano10q, Hor10d]. **Fetus** [JLLM+16]. **Fibrous** [GLLS14]. **Fidelity** [LC15, HTW17]. **Fieguth** [Lip12c]. **Field** [CY17, HM10, HM13, MLBM19, WYHT18, YT16]. **Field-Failure** [HM10, HM13]. **Fields** [JLLM+16]. **Fienberg** [Ano10t]. **Fighting** [SNY+10]. **Filling** [DSD12, JGBM19]. **Film** [Lip19c]. **Filter** [HGL+13]. **Filtering** [Ahm19a, SPS18]. **Filzmoser** [Lip10b]. **Finance** [Ano10e, Hor10a, Jar12b, Jar12a, Ors19]. **Financial** [Gho10b, Mye11b, Mye11c, SNY+10]. **Finding** [LMW19]. **Fingerprint** [LD11]. **Finite** [AHS16, HCT17, Hec10, LX18, Tan13, Mye12a]. **Finite-State** [AHS16]. **Finkelstein** [Jen10]. **First** [Ano11c, Hey12, McC12b]. **Fit** [PSR17, ZX17]. **Fixed** [MGJ14, TH18]. **FL** [Mar19a]. **Flaw** [TMMH17]. **Flaws** [LMT14]. **Flexible** [Gol12a, YZZ18]. **Flooding** [AGRI19]. **Flow** [ASDMLF16]. **Flowgraph** [HW10]. **Focused** [CCCC13]. **Foldover** [EJLN17, LL16]. **Follow** [KAT18]. **Follow-Up** [KAT18]. **Forecast** [PHD16]. **Forecasting** [AGMRS11, HLSR15]. **Forensic** [LM13]. **Forest** [Mye12b]. **Forgings** [LMT14]. **Form** [dCCT15]. **Foundations** [SB19]. **Fractional** [Grö14, LMZ19, RB10, SGS15, WMT12]. **Fractionated** [TW13]. **Frailty** [Bai12, Liu12]. **Framework** [DASS17, TMMH17, XMM16, ZJT11]. **Franceschetti** [Cha11]. **Francesco** [Ano11e, Cha12]. **Francisco** [Gru11]. **Francois** [Mye12c]. **Frank** [Che11b]. **Fraser** [Qiu12]. **Fraud** [BVW10, Han10]. **Frederic** [Ano12j]. **Frederick** [Ahm10, Ano10t]. **Free** [BJFB14, CM17, CZZ16, ML16, dCCT15]. **Free-Form** [dCCT15]. **Freedom** [CHKC10, Mic10]. **Frees** [Mye11b]. **Frequentist** [Gru11]. **Friedman** [Ano11g, Bha12]. **Frontier** [LACR11]. **Frontiers** [Ano11f, Jen11]. **Fronts** [LCAc13]. **Fuentes** [Bur12]. **Full** [DASS17]. **Function** [HLP13, LZ16, SWF16, TBMM15, WLHB15]. **Function-Based** [HLP13]. **Functional** [Ano12j, CM14, DGS13, Dri10, EPD18, GJL15, GAZ15, Ger15, HS19, HJM15, Mai11, MGSC18, SZ19, SGC14, Tan18, YPS18, YZW12,

ZCG+16, ZSGM14, ZCM+18, Bur10]. **Functions** [CBD+17, JWFW19, MGSC18, WHQ18]. **Fund** [Mye11a]. **Fundamentals** [Cin11, Ano11g, McC12b, Oli11a]. **Furberg** [Ano11g]. **Fused** [SWF16]. **Fusion** [HLSR15, NKCB14]. **Future** [ML16].

G [Ano10k, Ano12q, Ano16k, Ano17i, Ano18g, Bai11, Bre13, Bre14b, Bur10, BL11, Che12b, Gho12b, Hla15, Hor11a, Oli10a, Oli10b, Sar11]. **Galin** [Che12a]. **Gamma** [AMY14, Liu12, WW18, YXTC14]. **Gamst** [Oli10a]. **Gan** [Par11]. **Ganapati** [Lip12b, Nat12]. **Garrote** [PJR15, Xio10]. **Gary** [Ban11]. **Gatignon** [Ano10o]. **Gauge** [BMS10]. **Gaul** [Ano10j]. **Gaussian** [Fot10a, DLLR17, FOU13, GL12, GH16, Gui18, HS14, HCT17, HSL+13, KKS+14, KZS+18, LX18, LZHZ18, Mor12, Pen15, PSR17, RHK11, SCH17, TW12, Tan18, TL19, WX10, WB18, YC14, dCCT15]. **Gaussian-Process-Based** [SCH17]. **Gautam** [Mye11a]. **Gebhardt** [AA12]. **Geer** [Ano12m]. **Geert** [Gho11b]. **Gelfand** [Bur12]. **Gelman** [Che12a]. **General** [BDB15, GG12, SGS15, TG10]. **Generalized** [AMY14, CHS11, CYZ17, DP10, KRSW19, Oli12c, TC17, Zha10]. **Gentle** [Hin11]. **Geodesic** [dCCT15]. **Geometric** [Ano10f, DS17]. **Geometry** [Hor10a]. **Georg** [Mye11a]. **George** [Ano11o, Neu11, Ye10, Hun13]. **Geostatistics** [Cob10, LZ15]. **Gerald** [Neu10b]. **Gerardo** [WMI11]. **Gerhard** [Ano10q]. **Gesellschaft** [Ano11u]. **Gibbs** [Laz11]. **Gibilisco** [Ano10f]. **Gillet** [Mye12c]. **Gine** [Ano11n]. **Given** [WLHB15]. **Glaz** [Nag11]. **Glenn** [Hor10b]. **Global** [CG16, LWM13, MKBN19]. **GOEM** [NHQ17]. **Gold** [DSM13]. **Gonena** [Gho10a]. **Good** [Oli12a]. **Goodness** [ZX17]. **Goos** [Atk12]. **Gore** [Nat12]. **GPS** [CM14]. **GPS-Enabled** [CM14]. **Grading** [WLWZ16]. **Graham** [Sau12]. **Gramacy** [CL16]. **Graphical** [Bha12, LX18]. **Graphically** [Apl12]. **Graphics** [Hec11]. **Graves** [Bur10]. **Greedy** [QLS+19]. **Greenacre** [Ano11e]. **Gregory** [Lip12a]. **Grids** [LVB13]. **Group** [MDS12, QLS+19, SAH+17]. **Grouping** [Gui18, WSZ14]. **Growth** [GJ10, HEM10a, HEM10b, O'C10, Par14, SF10, Sin10, WAC10, WHQ18, ZDH14]. **Gruber** [Ano11j]. **Guarino** [Oli10a]. **Guide** [Ano12c, Bai11, Bzi11, Hor10b, Neu12a, Oli12a, Van10, Sar11]. **Guidelines** [ACH14, SWWR14]. **Guide(R)** [Rut12]. **Guido** [Ano10m]. **Gunther** [Boo10b]. **Guojun** [Par11]. **Gusak** [Mye11c]. **Gut** [San11]. **Guttorp** [Bur12].

H [Ano10r, Ano10d, Ano11j, Bai11, Ban10b, Hor12a, Jen11, Mye11a, Oli12c, Syl12]. **Hahn** [Neu10b]. **Half** [EG12]. **Half-Half** [EG12]. **Hall** [Ano11l]. **Halloran** [Wie11]. **Hamann** [Mye12b]. **Hanagal** [Bai12]. **Hand** [Qia10a]. **Handbook** [Ano10s, Ano12r, Pfa12, Bur12, Che12a]. **Hans** [Ano10j, Neu12a]. **Hans-Hermann** [Ano10j]. **Hans-Michael** [Neu12a]. **Hard** [AG12]. **Hard-to-Change** [AG12]. **Hardback** [Mar19a]. **Hardle** [Jar12b]. **Hardware** [CMR10]. **Harper** [Cob10]. **Harris** [Ano10s]. **Harry** [Chi12c]. **Hastings** [LKS16]. **Health** [Ban10a, Hor11a]. **Hedges** [Ano10s].

Hendry [Hor10d]. **Henry** [Ano10f, Hor12a, Hor10a]. **Henry-Labordère** [Hor10a]. **Herbert** [Ban10b, Bar10, Gol11a]. **Hereditary** [Hor10c]. **Heredity** [LZ14]. **Hermann** [Ano10j, Ano11u]. **Heterogeneous** [GW13, MLBM19]. **Hettmansperger** [Ano11k]. **Heyde** [Ano11l]. **Hidden** [Fra19]. **Hierarchical** [CHKC10, DGS13, HCT17, KL17, Li10, MLBM19, MMEDG14, PJR15]. **High** [AS16, CSY18, GFK+18, HRSV16, LSP13, LMS15, MKBN19, Mar11, PTZ19, PH16, QLS+19, Qu10, VWGR11, WSZ14, XQW13, YPS18, ZHOY13, ZLD16, ZWZJ15]. **High-Accuracy** [XQW13]. **High-Dimensional** [GFK+18, HRSV16, LMS15, Mar11, PTZ19, PH16, WSZ14, YPS18, ZHOY13, ZLD16, ZWZJ15]. **High-Performance** [AS16]. **High-Reliability** [VWGR11]. **High-Resolution** [MKBN19]. **High-Throughput** [Qu10]. **Highly** [Lip11b]. **Hilbe** [Gol11c, Qu12, Ros11]. **Hilbert** [BLK19, YZZ18]. **Hiroshi** [Lip10a]. **Hirukawa** [Gho10b]. **History** [BVW10, WND+18]. **Hoaglin** [Ano10t]. **Hoff** [Hey12]. **Hoijtink** [Bar10]. **Honor** [Ano11f]. **Honour** [Ano10q, Hor10d]. **Hooker** [Bur10]. **Horton** [Hec11]. **Hothorn** [Che11b, Pfa12, Yu12]. **Hourly** [CJL14]. **Howard** [Ke11b]. **Hsiung** [Hor10c]. **HTS** [LSP13]. **Huan** [Lip10a]. **Huber** [Ano10e, JWFW19]. **Huber-Carol** [Ano10e]. **Hubert** [Ano10o]. **Hui** [Ano11f]. **Humanities** [Lip19c]. **Hunter** [Ano16k, Ano17i, Ano18g, Bre13, Bre14b, Hla15, Cho11, Cho12, Mit10]. **Hygiene** [MBR14]. **Hyman** [WMI11]. **Hypercube** [BMB15, DP10, DASS17, HQH16]. **Hyperspectral** [BWMG14, SHL15]. **Hypotheses** [Ano11p, Bar10]. **Hypothesis** [HLP13, SZ19].

Identification [CGB+14, HL17]. **Identifying** [QX14]. **Ieno** [Bai11, Oli10b]. **IFCS** [Ano11u]. **II** [Hor10b, WYJ10]. **Image** [FPG19, FQ18, KMQ18, Lip12c, MGSC18, MQ11, Par14, Qiu12, QX13]. **Image-Based** [FPG19]. **Images** [BWMG14, CGR+15, FQ18, HP12, SHL15, SYW19, TEN14, TMMH17, YPS17, ZZD+14]. **Imaizumi** [Ano10j]. **IML** [Sea11a, Sea12]. **Imperfect** [SB19, ZX17]. **Implicit** [AS16]. **Importance** [CBC15, LVB13, ZW17]. **Improved** [HN12, TMMH17, TG15]. **Improvement** [CW16, For13, Gra13, ZX17]. **Improving** [LCAc13, Zha10]. **In-Plane** [SHD18]. **Inaccuracy** [WH19]. **Incorporating** [HRC10, HW10]. **Independence** [SG18]. **Index** [Ano10z, Ano11w, GL12, WX14]. **Indexes** [Ano10m]. **indicator** [Lip12b]. **Indirect** [Esp11]. **Individual** [LMZ19]. **Individuality** [LD11]. **Individuals** [QX14]. **Industrial** [MBR14]. **Industry** [Ano10e, Neu10b]. **Inference** [AGMRS11, Ano10k, Ano10d, Bur11, Car14, DNV16, FK14, Fra19, Gho10b, GB18, Guo19, Haz10, KMM11, LAMO+16, SWW+16, SB19, SS15, SHG12, TG17, WYJ10, WW18, ZCW19, Ano10i, Sea11b]. **Inference-Data** [Guo19]. **Influence** [RMZ15, XMM16]. **Info** [SB19]. **Info-Metrics** [SB19]. **Informatics** [Ano13h]. **Information** [GW13, HN12, HM10, HM13, HDM+15, LMZ19, SB19, Tan18, YT16]. **Informative** [Bar10, PJR15]. **Infrared** [BFK+12]. **Ingo** [Hor11f]. **Initial**

[Tan18]. **Inputs** [Mor12]. **Inquiry** [Lip19e]. **Inspection** [QWKR14]. **Insurance** [Jar12b]. **Integer** [SSG15]. **Integrated** [Ano10g, Bur11]. **Integration** [CRBM19, ZM19]. **Intelligence** [PCWW16]. **Intensive** [Ano12f]. **Interactions** [DWD+14, ES17, Grö14, WMT12]. **Interactive** [QLS+19]. **Interdependence** [CS12, DF12, JSQ12, JS12a, JS12b, LW12, WSZ12]. **Intermediate** [Ke11a, San11]. **Internal** [SRZ+19]. **International** [Ahm19b]. **Interpolation** [Jos12a, RHK11, Tan15b]. **Interpreting** [Sar11, TS12, McC10]. **Intertwining** [Lip12d]. **Interval** [JAP15, WLHB15]. **Interval-Valued** [JAP15]. **Intervals** [Ruk15]. **Introducing** [Neu11]. **Introduction** [Boo10b, Hly10a, Lip12b, Yu12, Ano10l, Laz11, Lip10b, Ng11, Sym11]. **Inverse** [JK11, Oli12c, Pen15, Tad13, TBMM15, THS15, WX10, YC14]. **Inversion** [MMEDG14]. **Inversions** [CGR+15]. **Irene** [Bar10, Cha12]. **Irregular** [QX14]. **ISBN** [Ahm19b, Mar19a]. **ISBN-13** [Mar19a]. **Ishwar** [Ano11l]. **Isobel** [Cob10]. **Isotonic** [THT11]. **Issue** [Ano13h, CCCC13, Ste10b]. **Issues** [Gol12b]. **Iterated** [Bor12].

J [Ano10r, Ano11e, Ano11j, Ano12p, Ban11, Bur10, Che11a, Gru11, Hec11, Hly11, Hor10b, Hor11a, HS17, Jen11, Neu10b, Oli10a, Oli10c, Oli10b, Qia10a, Sea11a, Wie11]. **Jack** [Ano12n, Che11a]. **Jackman** [Mag11]. **Jacobs** [Ban10a]. **Jake** [Ano10h]. **James** [Ano11f, Che12b, Hin11, WMI11]. **Jamis** [Sea11a]. **Jane** [Wlu12]. **Jank** [McC12a]. **Javier** [Ano12k]. **Jay** [Fot10a]. **Jeff** [Mye12b]. **Jeffery** [Mar19a]. **Jeffrey** [Ano10s, Ano12g]. **Jennifer** [Hor10d]. **Jensen** [Fot10b]. **Jiang** [McC12c]. **Jianhong** [Par11]. **Jiming** [McC12c]. **JMP** [Sar11, Wlu12]. **John** [Ng12]. **Johnson** [Hor10b]. **Joint** [DJ15, HL17, LRL+12b, LRL+12a]. **Jon** [Lip11b]. **Jonathan** [Qia10b]. **Jones** [Che12a, Ng11, Atk12]. **Jose** [Sar11]. **Josef** [Wlu12]. **Joseph** [Ano11k, Gol11c, Nag11, Qu12, Ros11]. **Jr.** [Chi12c]. **Judea** [Ano10i]. **Judgment** [Gol11a]. **Judith** [Ano10t]. **Jump** [KQ14]. **Jumps** [TH10]. **Junge** [Ano11u]. **Junichi** [Gho10b]. **Jurgen** [AA12]. **Just** [Bzi11]. **Justin** [Ban11].

Kahle [Ano10e]. **Kalman** [HGL+13]. **Kaltenbach** [Neu12a]. **Karen** [Che12b]. **Karl** [Mye12a, Qiu12]. **Keener** [Qu11]. **Keh** [Hor12d]. **Keh-Shin** [Hor12d]. **Kelbert** [Hly10b]. **Kelly** [Hly12]. **Ken** [Hec11]. **Kenett** [Ahm10]. **Kenichiro** [Gho10b]. **Kennedy** [Ke11a]. **Kenneth** [Ano11d, Ano11h]. **Kernel** [AS16, BLK19, JAP15, WZ19, YZZ18]. **Keying** [Ano11f]. **Khuri** [Oli11b]. **King** [Mic10]. **Klein** [Ano12q]. **Kleinbaum** [Ano12q]. **Kleinberg** [Lip11b]. **Kleinman** [Hec11]. **Klugkist** [Bar10]. **Kneib** [Ano10q]. **Knowledge** [Ano11u]. **Koehn** [Hor11c]. **Kolaczyk** [Fre12]. **Koller** [Bha12]. **Koltchinskii** [Ano11n]. **Koop** [Ban11]. **Kragh** [Lip11c]. **Kriging** [CGB+14, GB18, PT14, PA17, PR17, TH18, WH19]. **Kriging-Based** [CGB+14]. **Krishnamoorthy** [You10]. **Kroese** [Ano10n]. **Krzanowski**

[Qia10a]. **Kukush** [Mye11c]. **Kulik** [Mye11c]. **Kung** [Qia10b]. **Kung-Sik** [Qia10b]. **Kurt** [Lip10b].

L [AA12, Ano11g, Ano12g, Ano12k, Ban11, Gho12a, Hor10d, Hor12c, Mar19a, Oli10a]. **Labordère** [Hor10a]. **Lagged** [TS16]. **Lagrangian** [CL16, GGL+16a, PGK16]. **Lang** [Kat11]. **Lange** [Ano11d, Ano11h]. **Laplace** [Bor12]. **Large** [Ano12n, cCOP+13, KH19, MLF+16, NS15, NKCB14, NHQ17, PSB+13, QL19, RB10, VX19, YR11, McC12c]. **Large-Scale** [NHQ17]. **Large-Vector** [NS15]. **Larry** [Ano10s]. **Lasso** [CRW18, SWF16, TS16, SHL15, ZJT11]. **LASSO-Based** [ZJT11]. **Latent** [Lip19a, XTP17]. **Latin** [DASS17, BMB15, DP10, HQH16]. **Lattice** [QAHS14, Kuh10]. **Laurent** [Lip11a]. **Lauro** [Ano11e]. **Lavallée** [Esp11]. **Law** [SS15, Jen10]. **Lawrence** [Ano11g]. **Lawson** [Li10]. **Lawton** [Syl12]. **Lazar** [Mai11]. **Learned** [BVW10]. **Learning** [Che12b, Fre13, Lip19d, The13, ZCG+16, ZZZ+15, Ano10l]. **Least** [Ahm19e, CM11, CS16, SPS18, XDHQ16, ZL17]. **Least-Squares** [CS16, ZL17]. **Lectures** [Gho19, Hor11b]. **Lee** [Che11a, Ban10b]. **left** [KMM11]. **Legendre** [Mye12c]. **Lehmann** [Ano12k]. **Lemieux** [Ng10]. **Lene** [Lip11c]. **Lenz** [Jen11]. **Lessons** [BVW10]. **Letter** [ANAC14, Con10]. **Level** [AG12, Edw11, ES17, EJLN17, Grö14, HL17, MSE17, PCWW16, SdCR12, Van10, VX19, VGS19, XHM+17]. **Leveraged** [BMS10]. **Li** [Che12a]. **Libraries** [SWMW13]. **Life** [LHTD18, Liu12, Mye12a]. **Lifetime** [Ano10d, CY17, ZTEM17, WYJ10]. **Lifted** [PA17]. **Lifting** [HNKF18]. **Lii** [Hor12d]. **Likelihood** [Bur11, OY17, SCH17, SGC14, Wad16, XC10]. **Limits** [EW10, Hof10, ZPM14]. **Limnios** [Ano10e]. **Lin** [Che11c]. **Linear** [CZ15b, Lip11c, MZ13, PFF14, PSR17, SSG15, Sea11a, SZ19, SGC14, TML16, YR11, ZLD16, ZDH14, Gho11b, Oli11b]. **Liners** [GGP10]. **Liu** [Lip10a, Qiu12]. **Local** [Fot10a, GH16, KMQ18, MQ11, PD11, PR17]. **Locally** [NHB+13]. **Locarek** [Ano11u]. **Locarek-Junge** [Ano11u]. **Location** [BJFB14, DLY+17, EW10, HLP13, HL17, RTA11]. **Location-Scale** [HLP13]. **Log** [AMY14, EW10, ZLD16]. **Log-Gamma** [AMY14]. **Log-Linear** [ZLD16]. **Log-Location-Scale** [EW10]. **Logical** [Lip12a]. **Logistic** [ZPM14, Ros11]. **lognormal** [KMM11]. **Lonardi** [Ano10h]. **Long** [BWMG14]. **Long-Wave** [BWMG14]. **Longini** [Wie11]. **Longitudinal** [Gho11b, Gho12a, Gol12c, QX14]. **Lorenzo** [Lip12d]. **Loss** [TW12]. **Low** [JSMS15, XQW13]. **Low-Accuracy** [XQW13]. **Ludwig** [Ano10q]. **Luigi** [Ano10p, Ano10m]. **Luis** [WMI11]. **Lumber** [WLWZ16, YZW19]. **Lyle** [Boo10a].

M [Ano10t, Ano10e, Ano11n, Ano11g, CZ15a, Che11a, Gol11c, Hor12d, Mye11a, Oli10c, Oli10b, Qu12, Ros11, Wie11, WMI11, CZ15a]. **M/M/1** [CZ15a]. **Ma** [Par11]. **Machine** [Ano10l, Hor11c, The13, WB18, Lip19d]. **Machines** [AS16, Hor11f]. **MacroPCA** [HRV19]. **Magnani** [Lip12d]. **Mahalanobis** [GJL15]. **Maillardet** [Ng11]. **Main** [Bag10, ES17].

Main-Effect [Bag10]. **Maintainability** [CMR10]. **Maintenance** [ZX17]. **Making** [Ano11f, Lip19f, Hor10b]. **Maller** [Ano11l]. **Malley** [Che12b]. **Malware** [KRSA15]. **Management** [Ano10o, GJ10, HEM10a, HEM10b, Hec11, O'C10, SF10, Sin10, WAC10, Mye11a, Wlu12]. **Managers** [McC12a]. **Manifolds** [CRBM19]. **Manipulation** [Sau10]. **MANOVA** [Zha11]. **Mantovan** [Ano12f]. **Manufacturing** [DJ15, SHD18, dCC11]. **Mapping** [Li10]. **Marasinghe** [Ke11a]. **Marco** [Ban10b]. **Marcus** [Fot10a]. **Margin** [QL19]. **Marginal** [MW19]. **Maria** [Ano10f]. **Marine** [GGP10]. **Mark** [Hly10b]. **Marked** [LD11]. **Market** [AGMRS11]. **Markets** [Lip11b]. **Markov** [Che12a, Hly10b, AHS16, CMR10, Fot10a]. **Marks** [LM13]. **Markus** [Neu12b]. **Marten** [Ano12m]. **Martin** [Hor12a]. **Martinez** [Ano12g, Mar19a]. **Marvin** [Ano11j]. **Masanobu** [Gho10b]. **Massimo** [Cha11]. **Massive** [BFK$^+$12, GB18]. **Massoulie** [Lip11a]. **Matched** [The13]. **Matched-Pair** [The13]. **Matching** [PSR17, WND$^+$18]. **Material** [SYW19]. **Materials** [DNV16]. **Mathematical** [WMI11]. **Mathematica**^{TM} [Lip12a]. **Mathematics** [Ano12c, Mye11c, Mye12a, Bar11]. **Mathew** [You10]. **Mathias** [Hor11b]. **Matilde** [Ano10p]. **MATLAB** [Ano12g, Bur10, Mar19a]. **Matrices** [Car14, Haz10, Oli12c, Zha11, Ano12n]. **Matrix** [DS17, Lu11, ZS15]. **Maximin** [SdCR12]. **Maximum** [SCH17, Wad16, WLHB15]. **May** [Ano12h]. **Mayo** [Ano10k]. **MCEM** [XC10]. **McKean** [Ano11k]. **MCMC** [FNL11]. **Mean** [Apl12, TS12, TH10, KMM11]. **Means** [MW19, Wlu12]. **Measure** [WC12]. **Measurement** [DSM13, DMW10, LG13]. **Measurements** [CRCH18, PGS11, PHD16]. **Measures** [GAZ15, WMEW13]. **Measuring** [Tad13, XMM16, Ban10a]. **Medhi** [Hly11]. **Medical** [Hec10]. **Medicine** [Lip19d, Boo10a]. **Mee** [Van10]. **Meester** [Cha11]. **Meesters** [Bai11]. **MEG** [THS15]. **Memoriam** [Hun13, Syl12, Chi12c]. **Meng** [Che12a]. **Mervyn** [Ke11a]. **Mesh** [TWY14]. **Meta** [GB18, LZ16, Ruk15, Ano10s]. **Meta-Analysis** [Ruk15, Ano10s]. **Meta-Kriging** [GB18]. **Meta-Modeling** [LZ16]. **Metamodels** [Tan17]. **Method** [BGMA14, HRV19, MW19, Nat12, THS15, WZ19, ZWZJ15, Ano10n, Mar19b]. **Methodology** [Hor10d, Oli11b]. **Methods** [Ano10p, Ano10f, Ano10m, BL11, Che11a, GJ10, Gui18, GW13, HEM10a, HEM10b, HDM$^+$15, Hor10b, Hor10a, Hor11d, Jar12a, JFEH14, Lip10a, Lip19a, LM15, MZ13, Mye12d, Nag11, Neu11, O'C10, SF10, Sin10, SFH$^+$13, SNY$^+$10, WMEW13, WAC10, Ano11k, Ano12f, Ban11, Hey12, Ke11a, Oli11a]. **Metrics** [GJ10, HEM10a, HEM10b, O'C10, SF10, Sin10, SB19, WAC10]. **Metropolis** [LKS16]. **Meyers** [Oli10a]. **Michael** [Ano11e, Fot10a, Jen10, Mye12a, Neu12a]. **Microarray** [Qiu12]. **Microarrays** [Ano12o]. **Microscopy** [CGR$^+$15]. **Microstructure** [SYW19]. **Mike** [Sea11b]. **Mill** [RKE10]. **Min** [Che11c]. **Ming** [Ano11f]. **Ming-Hui** [Ano11f]. **Mini** [Ste10b]. **Mini-Issue** [Ste10b]. **Minimal** [CJ14, JN11, LHDP14]. **Minimax** [Tan13]. **Minimum** [CYZ17, JDTW15, JWG$^+$19, LM15, RB10]. **Mining**

[Ano10d, Ano11o, Hor10b, Oli12a, Sau12, Ano10h]. **Misaligned** [LG13, MBR14]. **Misclassification** [DSM13]. **Mishura** [Mye11c]. **Missing** [HRV19]. **Mitchel** [Ano12q]. **Mithat** [Gho10a]. **Mitra** [Mye11a]. **Mixed** [Apl10, CMS10, Gho11b, Gol12c, PFF14, QZW10a, QZW10b, SSG15, Tsu10, WBD10, ZCM+18, Kat11, Oli10b]. **Mixing** [DLY+17]. **Mixture** [BDB15, Hec10, KJB11, KSB16, KH19, LX18, LWM13]. **Mixture-of-Mixtures** [KJB11]. **Mixtures** [KJB11]. **MMSE** [TC17]. **Mobile** [CM14]. **Model** [BWMG14, CBBJ18, CJL14, CJ14, cCOP+13, DGS13, Fra19, GGP10, GBH+13, HGL+13, HLSR15, JDLH16, JN17, KSB16, Kat11, KL17, LVB13, LG13, LZ14, LMT14, LZ15, Liu12, MLBM19, MMEDG14, Mor15, Oli11b, PSR17, PSB+13, RKE10, Ruk15, SHD18, SL18, SdCR12, SD15, SDR15, SGC14, TW13, TG10, TQW13, WX10, WX14, WB18, VWGR11, WB11, XHX17, YC14, ZLD16, ZX17]. **Model-Assisted** [LMT14]. **Model-Based** [cCOP+13, LZ15]. **Model-Robust** [SdCR12, SD15]. **Modeling** [Ahm19a, Ahm19c, Ahm19d, Ahm19e, Ano10e, Ano12f, Apl10, Ban10b, CM14, CWW17, CMS10, DJ15, GGL+16a, GB18, Hly10a, HSL+13, Hor10a, JSMS15, KJB11, KRSW19, KZS+18, Li10, LZ16, MBR14, Mye11b, Nku10, PHK+18, Pen10, QZW10a, QZW10b, RMVH11, Sea11b, SYW19, SB19, Tan18, TL19, Tsu10, TWY14, VSM13, WBD10, XMM16, XHM+17, YPP19, YCZ17, ZSGM14, ZZZ+15, dMvW10, CL16, Lip12c, Oli12a, Bai12]. **Modelling** [Ano10q, Ano12p, Lip19e]. **Models** [And11, Ano10i, AGV12, Bha12, BDB15, CG16, CBD+17, CBC15, CHKC10, DJ15, DLLR17, Dri10, EW10, EPD18, FK14, GAZ15, Gho11b, Gho12a, Gol11a, Gol12c, GL12, GACH10, GWN13, HN12, HRC10, HCT17, Hof10, HW10, ILS+17, JP13, KH19, LX18, LZ16, LZHZ18, LRL+12b, LRL+12a, Lip19a, MM19, ME12, Mor12, Oli10b, PD11, PFF14, PA17, PH16, TW12, TL16, TC17, Wlu12, XKHY18, XC10, YZW19, YR11, ZCW19, ZQZ11, ZCM+18, Bai12, Hec10, Ros11, Sea11a]. **Modern** [Oli11a]. **Modes** [Liu12, SNM10]. **Modified** [JWFW19]. **Moez** [Lip11a]. **Molenberghs** [Gho11b]. **Monari** [Ano10p]. **Monitoring** [Apl10, BA18, BH13, CM14, CZ15a, CMS10, FQ18, KZS+18, LCL12, LZHZ18, LMS15, MGSC18, PZQ16, PBH13, QZW10a, QZW10b, QZZ18, RTA11, Sen11, STZW16, SH14, TH10, Tsu10, VSM13, WMP18, WBD10, XWL18, YPS18, YZW12, ZQ18, ZSGM14, ZC18, ZWZJ15]. **Monograph** [Fot10b]. **Monotone** [LÇC12, TBMM15, YCZ17]. **Monotonic** [Tan16, Tan17]. **Monte** [Ano10n, Che12a, Mar19b, Neu11, Ng10, SH14, Ng10]. **Montserrat** [Bur12]. **Morality** [Lip12d]. **Most** [BFE+19]. **Mosteller** [Ano10t]. **Motion** [TQW13]. **Motoda** [Lip10a]. **Mou** [Hor10c]. **Mou-Hsiung** [Hor10c]. **Moving** [BH13]. **MR2655651** [RBM11]. **MR2664866** [Got10b]. **MR2752105** [Han10]. **MR2752106** [Han10]. **MR2967968** [Bor12, DM12, Lee12, OW12, SJ12]. **MR2967975** [LRL+12a]. **MRI** [Ahm19a, Mai11]. **Muenchen** [Gol11c, Sau11]. **Muller** [Ano11f, Che11a]. **Multi** [LC15, HTW17, Lip12b, TG17, XHM+17, ZC18]. **Multi-Fidelity**

[LC15, HTW17]. **Multi-indicator** [Lip12b]. **Multi-Level** [XHM+17]. **Multi-Parameter** [ZC18]. **Multi-Stratum** [TG17]. **Multicategory** [WZ19]. **Multichannel** [WMP18]. **Multiclass** [WZ19]. **Multidimensional** [CM11, Lip12c]. **Multifidelity** [GBH+13]. **Multilayer** [NS15]. **Multilevel** [GW13]. **Multinomial** [Tad13]. **Multiple** [AHS16, CGR+15, GLLS14, HN12, ILS+17, LACR11, MM19, Par14, PHD16, RMZ15, SWMW13, SDR15, Che11b]. **Multiple-Case** [RMZ15]. **Multipollutant** [JP13, PHK+18]. **Multiscale** [MMEDG14, Ban10b]. **Multisite** [PHK+18]. **Multistratum** [GG12, TG15]. **Multivariate** [Ano12h, BJFB14, CM17, CJL14, CZZ16, CZ15b, FOU13, HRC10, JP13, KRSW19, KKS+14, KZS+18, Kuh10, LZ15, LZ16, LZHZ18, Lip10b, PD11, PHK+18, PZQ16, SG18, TS12, TML16, WMP18, XC10, Yu12, ZJT11, ZT11]. **Murray** [Bur11]. **Murrell** [Sym11]. **Myatt** [Hor10b].

N [Ahm19b, Ano10e, Bai11, Hor12d, Oli10b]. **Naes** [Hor11e]. **Nanocomposites** [ZZD+14]. **Nanoparticle** [DLY+17, SWW+18]. **Nanostructures** [ZDH14]. **Nanotubes** [SRZ+19]. **Narayan** [Hly10a]. **NASA** [BFK+12]. **Nason** [BL11]. **Natale** [Ano11e]. **Nature** [MKBN19, SAR16]. **Nearest** [SG18]. **Nearly** [THT11]. **Nearly-Isotonic** [THT11]. **Necip** [Neu10b]. **Need** [SWWR14]. **Negative** [Qu12]. **Neighborhood** [GH16]. **Neighbors** [SG18]. **Neil** [Hor10d, Rut12]. **Nested** [GJ19, QAHS14]. **Net** [SAH+17, WSZ14, ZLD16]. **Network** [Fre12, VSM13]. **Network-Wide** [VSM13]. **Networks** [Cha11, Lip19f, PGS11, Ano10d, Hly12, Lip11a, Lip11b]. **Neuhauser** [Neu12b]. **Neural** [Ano10d]. **Neuronal** [ZCG+16]. **Neuroscience** [Ahm19d]. **Neutron** [BH13]. **Niche** [Pen10]. **Nicholas** [Hec11]. **Nicole** [Mai11]. **Nikolaos** [Ano10e]. **Nikulin** [Ano10e]. **Nir** [Bha12]. **Noise** [Ahm19a, BN12, JSMS15, Sen11, SRZ+19]. **Noisy** [PGRC13a, Ran13]. **NoMax** [HWL16]. **Nominations** [Ano16k, Ano17i, Ano18g, Bre13, Bre14b, Hla15]. **Non** [Wv11]. **Non-Normal** [Wv11]. **Nonbipartite** [PSR17]. **Noncollapsing** [DSD12]. **Nonconvex** [PHBF17]. **Nondestructive** [LMT14, TMMH17]. **Nonhomogeneous** [RWP15]. **Noninferiority** [Ano11p]. **Nonlinear** [Got10b, Got10a, SAR16, WC12]. **Nonlongitudinal** [Par14]. **Nonnegative** [DS17, Jos13, PJR15, Xio10]. **Nonorthogonal** [MSE17]. **Nonparametric** [Ano11k, Apl10, BWMG14, CMS10, GWN13, JAP15, KMQ18, KRSA15, KZS+18, LX18, LHDP14, MZ15, MQ11, QZW10a, QZW10b, QL11, QX13, QZZ18, RTA11, SWMW13, SHG12, Tsu10, WBD10, XWL18, Neu12b]. **Nonrectangular** [DSD12]. **Nonregular** [VX19]. **Nonseparable** [FOU13, LZ16]. **Nonstationary** [HCT17, PSB+13, TMAZ18]. **Normal** [Wv11]. **Norvaisa** [Ano11n]. **Note** [Grö14, Jos13, LL16, MZ13]. **Notes** [Xio10]. **Novak** [Jar12a]. **Novel** [Nat12]. **Numerical** [CBD+17, Ano11h, Mye12c]. **Núñez** [Gho12a]. **Núñez-Antón** [Gho12a].

O [Ano11f, Jen10]. **Oberwolfach** [Hor11b]. **Object** [Par14]. **Objectivity** [Ano10k]. **Observational** [Gol11b, Nat12]. **Observations** [LZHZ18, ML16, Pie13, YZW12]. **Observing** [MKBN19]. **Ogunnaike** [Cin11]. **Okada** [Ano10j]. **Oliver** [Hor11e]. **Olivier** [Gho11a]. **One** [AG12, Hof10, HRV19, ZC18]. **One-Sided** [Hof10, ZC18]. **Online** [JDLH16, LMS15, NHB+13, RKE10, SWW+16, XWL18, ZWZJ15]. **Only** [YT16]. **Onset** [VWGR11]. **Operating** [Gho10a]. **Oppenlander** [Wlu12]. **Optimal** [ASDMLF16, BMB15, Edw11, GJ19, HN18, LMW19, MGJ14, PSR17, Qu10, SRZ+19, Tad13, ZHOY13, ZDH14, AA12, Atk12, Gho10b]. **Optimality** [HN18]. **Optimization** [AS16, CW16, CL16, FD15, GGL+16a, HTW17, LACR11, MW19, PGRC13a, SCH17, SRZ+19, TW12, YPP19]. **Optimizing** [PCWW16]. **Optimum** [SNM10, TL16]. **Option** [Hor10a]. **Order** [Lip12b]. **Ordered** [TS16]. **Ordinal** [CRCH18, dMvW10]. **Ordinary** [LZW15]. **Organization** [Ano11u]. **Orientation** [SGH13]. **Orientations** [DNV16, SWW+18]. **Origin** [Car14, Haz10, Sen11]. **Origin-Destination** [Car14, Haz10]. **Orthogonal** [Bag10, Edw11, HQH16, MSE17, SSG15, SGS15, VGS19]. **Orthogonalizing** [XDHQ16]. **Orthonormal** [Tan15a]. **Other** [CHKC10, KSB16, Pie13]. **Othmar** [McC10]. **Outbreak** [SB10]. **Outcomes** [EDR16]. **Outdoor** [HDM+15]. **Outlier** [YZW12]. **Outliers** [Far14, HS19, HRSV16, HRV19, PD11]. **Output** [Dri10, JDLH16, LZ16, Tan18]. **Outputs** [GBH+13, HWL16, Mor12]. **Over-Specified** [CBD+17]. **Overview** [Lip19d]. **Owen** [Ng11].

P [Ano10r, Ano10n, Ano10f, Ano11k, BL11, Che11a, Hly12, Hor10b, Hun13, Jar12b, Jen11, Lip12b, Mye12b, Nat12, Neu11, Oli12a]. **Pacelli** [Bar11]. **Packet** [PGS11]. **Packets** [Mal19]. **Packing** [He19]. **Pair** [The13]. **Pairwise** [FP17, LZ16, LZHZ18]. **Pajevic** [Che12b]. **Palumbo** [Ano11e]. **Panel** [BFE+19]. **Paola** [Ano10p]. **Paolo** [Ano10f]. **PAPERS** [Ano13h]. **Paradis** [Ano12d]. **Parallel** [cCOP+13, CGB+14, GACH10]. **Parameter** [Got10b, Got10a, HLBS19, She17, TW13, Tan15a, WC12, XC10, ZC18]. **Parameterized** [CHKC10]. **Parameters** [Ruk15, SNM10, ZDH14]. **Parametric** [ZTEM17, ZYH14, dCCT15]. **Pareto** [CYZ17, KRSW19, LACR11, LCAc13, Zha10]. **Partial** [Ahm19e, CS16, Lip12b, ZL17]. **Particle** [LPVW13, LMW19, SPS18]. **Particles** [ASDMLF16, ZZD+14]. **Partition** [GLLS14]. **Partition-Based** [GLLS14]. **Partitioning** [CHKC10, MLF+16]. **Path** [Ahm19e]. **Pathways** [Par14]. **Patil** [Nat12, Lip12b]. **Paul** [Ano12e, Bar10, Gol11b, Lip12c, Sym11]. **PCA** [HRSV16, HRV19, MGSC18]. **Peaks** [KRSW19]. **Pearl** [Ano10i]. **Penalized** [FPG19, GFK+18, HLBS19]. **Performance** [AS16]. **Periodic** [SHG12]. **Permutation** [Gui18]. **Permutations** [LL16, WHQ18]. **Perret** [Sea11a]. **Perspective** [EDR16, Kle13, Ban10b]. **Perturbation** [Lu11]. **Peter** [Ano11f, Ano11l, Atk12, Ban10a, Bur12, Che11a, Che11b, Hec10, Hey12, Lip10b, Nku10]. **Pfaff**

[Ano10g]. **Pflug** [Mye11a]. **Pharmacogenomics** [Che11c]. **Phase** [TH10, BJFB14, CM17, PZQ16, WMP18, ZQ18]. **Phase-I** [PZQ16]. **Phenomena** [Cin11]. **Phil** [Lip12a, Sau10]. **Philipp** [Hor11c]. **Philosophical** [Lip12d]. **Phones** [CM14]. **Phylogenetic** [Ano12d]. **Physical** [LMT14, Lip12a, MBR14, Mor15]. **Piccolo** [Ano10p]. **Piecewise** [WX14]. **Piera** [Ano10f]. **Piercesare** [Ano12f]. **Pierre** [Esp11, Hor10a, Mye12c]. **Pietro** [Ano12f]. **Pilipenko** [Mye11c]. **Pilz** [AA12]. **Pipeline** [LM15]. **Piquero** [Ano12r]. **Pixel** [KMQ18]. **Plane** [SHD18]. **Planning** [Liu12, WMEW13, YXTS12]. **Plans** [Bag10, Edw11, TBMM15]. **Platform** [Hor12b]. **Pleasure** [Ano10t]. **Plot** [EG12, GG12, Mic10, MGJ14, SGS15, TW13, TG15, TG17]. **Point** [HN12, PZQ16, RMVH11, SGH13, WLHB15, YPP19]. **Pointwise** [ZPM14]. **Poirier** [Ban11]. **Poisson** [ME12, RWP15, STZW16]. **Poli** [Cha12]. **Policy** [Lip19e, Ban10a]. **Political** [Tad13]. **Politics** [Bar11]. **Politis** [Hor12d]. **Polynomial** [Tan15b, WLHB15]. **Polynomials** [Tan15a, Tan16]. **Population** [STZW16]. **Populations** [SAC17, SFH+13]. **Portal** [BH13, PBH13]. **Posterior** [Apl12, FNL11]. **Posteriors** [JWG+19]. **Potential** [EDR16]. **Power** [Bar11, LVB13, SS15]. **Power-Law** [SS15]. **Pozdnyakov** [Nag11]. **pp** [Ahm19b, Mar19a]. **Practical** [And11, Bre14a, Hor10b, Ano12h, Cob10]. **Practicalities** [For13]. **Practice** [Hor10d, Ano10m]. **Practitioner** [Oli12a]. **Practitioners** [ACH14, SWWR14]. **Prado** [Sea11b]. **Precision** [LCAc13, PGRC13a, TQW13]. **Predicting** [XHX17]. **Prediction** [And11, BLK19, GBH+13, GH16, HM10, ML16, RKE10, SYW19, VSM13, WLWZ16, ZM19]. **Predictions** [HG11, HM13, Pen10]. **Predictive** [ZZZ+15]. **Predictor** [CS16]. **Predictors** [Lip11c]. **Preferential** [SWW+18]. **Presence** [DWD+14, EW10, Far14, GJ19, SRZ+19, ZCW19]. **Press** [Mar19a]. **Price** [CJL14, Ano10m]. **Pricing** [Hor10a]. **Primer** [Hly10b, Hor12a, Neu12c]. **Principal** [CFF13, WMP18]. **Principle** [TL19]. **Principles** [Bha12]. **Printing** [ZQ18]. **Prior** [ML16, WND+18]. **Prior-Free** [ML16]. **Prioritization** [Lip12b]. **Priors** [GLLS14, JFJ+19]. **Prize** [Ano10c, Ano11b]. **Prizes** [Ano10a, Ano10b, Ano11a, Ano12a, Ano13a, Ano16b, Ano19a, Ano14f, Ano17a]. **Probabilistic** [ML16, Bha12]. **Probability** [Cin11, Hor12c, Jen10, Laz10, Laz11, LMT14, McC12b, MGSC18, SAC17, Ano11d, Fot10b, San11, Ano11i, Ano12i, Hly10b]. **Probit** [XC10]. **Problem** [THS15]. **Problems** [Bre14a, CRBM19, Lip19f]. **PROC** [Ke11b]. **Procedures** [Cha12]. **Proceedings** [Ano11u]. **Process** [Apl12, DLLR17, FOU13, GL12, GH16, Gui18, HCT17, HSL+13, KL17, KKS+14, LQ14, LZHZ18, LMS15, QL11, RHK11, SCH17, SS15, TW12, Tan18, TL19, TH10, WX10, WB18, XMM16, XTP17, XHM+17, YPP19, YC14, YCZ17, ZJT11]. **Processes** [BLK19, Fot10a, HS14, Hly10b, KZS+18, LÇC12, LD11, MBR14, Mye11c, NSS11, Pen15, PSB+13, QL11, RWP15, RZ16, TML16, WB18, YXTC14, ZTEM17, dCC11, dCCT15, Hly11]. **Processing** [Lip12c, SPS18]. **Products** [YXTC14, Ano10p]. **Profile**

[Apl10, AGRI19, CMS10, LZHZ18, MGSC18, PZQ16, QZW10a, QZW10b, SAR16, Tsu10, WMP18, WBD10, YZW12]. **Profiles** [HRC10]. **Prognosis** [KZS+18]. **Prognostics** [FPG19]. **Programming** [Ng11, Ng12, Oli10c, Rut12, SSG15, Sea12]. **progressively** [WYJ10]. **Projection** [Oli12c]. **Proof** [Bar11]. **Properties** [For13]. **Protocols** [FD15]. **Publishing** [Ahm19b].

QPSO [LMW19]. **QQ** [DJ15]. **Quadratic** [TW12]. **Qualitative** [DJ15, DLLR17, HLLY16, ZQZ11]. **Quality** [Ahm10, Ano10p, DJ15, Jen11, JFEH14, TS12, XTP17]. **Quantification** [CWW17, MMEDG14, Tan15b]. **Quantifying** [AGRI19, DLY+17, NAEK15, WLWZ16]. **Quantile** [For13, GFK+18, PBH13, PGRC13a, PT14, SWF16, Tan16, YCZ17]. **Quantile-Based** [PGRC13a]. **Quantiles** [PTZ19, KMM11]. **Quantitative** [Ano12r, DJ15, DLLR17, HLLY16, Ors19, ZQZ11, Hor12b, Mye11a]. **Quantum** [LMW19]. **Quantum-Behaved** [LMW19]. **Quasi** [Ng10, TC17]. **Quasi-MMSE** [TC17]. **Quasi-Monte** [Ng10]. **Queues** [CZ15a]. **Queuing** [Hly10a]. **Quick** [Bzi11]. **Quick-Start** [Bzi11].

R [AA12, Ano11n, Ano12g, Ano12o, Ano12r, Ban10b, Bur10, Gol11b, Hec11, Jar12b, Mar19a, Mye12a, Neu10a, Neu12c, Oli11a, AA12, Ano10g, Ano12d, Bai11, Boo10b, BL11, Che11b, Hor12a, Kuh10, Laz11, Mye12c, Mye12b, Neu11, Ng11, Oli10c, Oli10b, Pfa12, Qia10b, Sau10, Sau12, Yu12, Gol11c, Sau11]. **R&R** [BMS10]. **Radiation** [BH13, PBH13, SH14]. **Radiative** [FK14]. **Radiographic** [LG13]. **Rainer** [Lip12b]. **Rajendra** [Lu11]. **Ramirez** [Sar11, Sar11]. **Ramsay** [Bur10]. **Random** [Ano12n, CS12, DF12, Hly10b, Hof10, JSQ12, JS12a, JS12b, LW12, LRL+12b, LRL+12a, Pen15, SGH13, TH10, WSZ12, VWGR11, Cha11, Cin11]. **Randomization** [AS16]. **Rank** [TH18]. **Ranking** [Lip12b]. **Ranks** [SG18]. **Raquel** [Sea11b]. **Rasch** [AA12]. **Rate** [ASDMLF16, HM10]. **Rates** [DSM13]. **Ratio** [SGC14]. **Rationality** [Ano10k]. **Raton** [Mar19a]. **Rattle** [Sau12]. **Raymond** [Mye12a]. **Real** [JDLH16, YPS18]. **Real-Time** [JDLH16, YPS18]. **Reasoning** [Ano10k, Ano10i, Lip11b]. **Receiver** [Gho10a]. **Receptor** [HRC10, JP13, PHK+18]. **Reconstruction** [dCCT15]. **Recurrence** [XHM+17, ZYH14]. **Recurrent** [HW10, LÇC12]. **Reduction** [CSY18, CGB+14, MZ15, WX14, ZM19]. **Regions** [AGRI19, DSD12, PHBF17, Ruk15, Tan13, You10]. **Registration** [QX13]. **Regression** [Ano10q, CM11, CRW18, CZ15b, CS16, EW10, FPG19, Ger15, GFK+18, HLBS19, ILS+17, JK11, KQ14, KMQ18, KH19, Mar11, ME12, MQ11, PH16, RMZ15, Ros11, SWMW13, Tad13, Tan16, THT11, TS16, WSZ14, YPP19, YZZ18, YCZ17, ZLD16, ZL17, ZPM14, Qu12, Ano11j, Lip11c, Mye11b]. **Regression-Based** [JK11]. **Regularization** [THS15]. **Regularized** [LZW15, YPP19]. **Rejoinder** [AANC13, GGL+16b, HEM10b, JS12b, Jos12b,

PGRC13b, QZW10b, WLDD14]. **Related** [Ahm19c, Ano12j, SAC17]. **Reliability** [Ano10k, Ano10d, Ano10e, CMR10, CMAC12, CY17, CBC15, GJ10, GACH10, GW13, HEM10a, HEM10b, LCAc13, MLBM19, O'C10, SF10, Sin10, SAC17, SDR15, VWGR11, WAC10, WHQ18, YZW19, ZW17, Ahm10, Ano12e]. **Religion** [Lip12d]. **Remote** [NKCB14, ZCW19]. **Removal** [Ano18h]. **Renewal** [XHM+17, ZTEM17]. **Renming** [Hor12c]. **Repair** [LHDP14]. **Repeatability** [CRCH18, dMvW10]. **Repeated** [PGS11, WMEW13]. **Replicated** [LZHZ18]. **Replication** [BHGL19]. **Report** [Chi11, Chi12b, Chi13, Apl17, E19, Qiu14, Qiu15, Qiu16b, Ste10a]. **Reported** [WYHT18]. **Representation** [CWW17]. **Reproducibility** [CRCH18, dMvW10]. **Reproducing** [BLK19, YZZ18]. **Resampling** [Oli12a]. **Research** [Ano10s, Ano11u, CCCC13]. **Resolution** [MKBN19, TH18]. **Response** [HJM15, LMW19, SRZ+19, Wv11]. **Responses** [CM14, DJ15, GAZ15, MM19]. **Restricted** [SGC14]. **Retrospective** [Ger15]. **Return** [WYHT18]. **Returned** [YT16]. **Reversibility** [Hly12]. **Review** [AA12, Ahm19a, Ahm10, Ahm19b, And11, Ano10s, Ano10g, Ano10j, Ano10r, Ano10h, Ano10n, Ano10q, Ano10p, Ano10t, Ano10k, Ano10o, Ano10d, Ano10e, Ano10f, Ano10i, Ano10m, Ano10l, Ano11d, Ano11o, Ano11p, Ano11h, Ano11n, Ano11f, Ano11g, Ano11l, Ano11e, Ano11j, Ano11m, Ano11i, Ano11c, Ano11k, Ano12h, Ano12n, Ano12f, Ano12j, Ano12e, Ano12i, Ano12c, Ano12g, Ano12k, Ano12d, Ano12q, Ano12p, Ano12o, Ano12l, Ano12r, Ano12m, Atk12, Bai11, Bai12, Ban10b, Ban10a, Ban11, Bar10, Bar11, Bha12, Boo10b, Boo10a, Bur10, BL11, Bur11, Bur12, Bzi11, Cha11, Cha12, Che11c, Che11a, Che11b, Che12a, Che12b, Cin11, Cob10, Esp11, Fot10b, Fot10a, Fre12, Gho10b, Gho10a, Gho11a, Gho11b, Gho12a, Gho12b, Gho19, Gol11b]. **Review** [Gol11a, Gol12c, Gol12b, Gol12a, Gru11, Guo19, Hec10, Hec11, Hey12, Hin11, Hly10a, Hly10b, Hly11, Hly12, Hor10b, Hor10d, Hor10c, Hor10a, Hor11f, Hor11d, Hor11b, Hor11c, Hor11a, Hor11e, Hor12c, Hor12b, Hor12d, Hor12a, Jar12b, Jar12a, Jen10, Jen11, Kat11, Ke10, Ke11a, Kuh10, Laz10, Laz11, Li10, Lip10a, Lip10b, Lip11a, Lip11c, Lip11b, Lip12b, Lip12d, Lip12c, Lip12a, Lip19a, Lip19b, Lip19c, Lip19d, Lip19f, Lip19e, Lu11, Mag11, Mai11, Mar19a, Mar19b, McC10, McC12b, McC12c, McC12a, Mic10, Mye11a, Mye11b, Mye11c, Mye12a, Mye12c, Mye12b, Mye12d, Nat12, Neu10b, Neu10a, Neu11, Neu12c, Neu12b, Neu12a, Ng10, Ng11, Ng12, Nku10, Oli10a, Oli10c, Oli10b, Oli11b, Oli11a, Oli12c, Oli12a, Oli12b, Ors19, Par11, Pen10]. **Review** [Pfa12, Qia10b, Qia10a, Qiu12, Qu11, Qu12, Ros11, Rut12, San11, Sar11, Sau10, Sau11, Sau12, Sea11a, Sea11b, Sea12, Sen11, SB19, Sym11, Van10, Wie11, WMI11, Wlu12, Ye10, You10, Yu12]. **Reviews** [Ano10u, Ano10v, Ano10w, Ano10x, Ano11q, Ano11r, Ano11s, Ano11t, Ano12s, Ano12t, Ano12u, Ano12v, Ano13c, Ano13d, Ano13e, Ano13f, Ano14b, Ano14c, Ano14d, Ano14e, Ano15d, Ano15a, Ano15b, Ano15c, Ano16d, Ano16e, Ano16f, Ano16g, Ano17f, Ano17c, Ano17d, Ano17e, Ano18a, Ano18b, Ano18c]. **Reward** [Ahm19b]. **Riccomagno** [Ano10f]. **Richard** [Ahm19b, Hor12d].

Richly [CHKC10]. **Rick** [Laz10, Sea12]. **Ridge** [Mar11]. **right** [KMM11, WYJ10]. **right-censored** [WYJ10]. **Rimas** [Ano11n]. **Rinaldo** [Ano12i]. **Risk** [Hor12b, Mye11c, Ahm19b]. **Risks** [SS15, YXTS12]. **Robert** [Bzi11, Gol11c, Neu11, Ng11, Qu11, Sau11, Van10]. **Roberto** [Cha12]. **Robinson** [Mye12b, Ng11]. **Robust** [AMY14, BN12, CRW18, CFF13, DMW10, Far14, FD15, Got10b, Got10a, JWFW19, LSP13, MW19, Mar11, ME12, SD12, She17, SdCR12, SD15, TW12, TW13, Tan15a, THS15, Ano11k]. **Robustness** [JGBM19]. **ROC** [Qia10a]. **Rogantin** [Ano10f]. **Rojo** [Ano12k]. **Role** [Neu10b]. **Rolling** [RKE10]. **Ron** [Ahm10]. **Ronald** [Cha11]. **Rongling** [Che11c]. **Rosen** [Fot10a, GLLS14]. **Rosenbaum** [Gol11b]. **Rosenblatt** [Hor12d]. **Ross** [Ano11l]. **Rotated** [He19]. **Rotations** [SGH13]. **Row** [Qu10]. **Row-Column** [Qu10]. **Rowena** [Ban10a]. **Rowwise** [HRV19]. **Rubinstein** [Ano10n]. **Rueven** [Ano10n]. **Ruggeri** [Ahm10]. **Rule** [TL16]. **Rumours** [Lip11a]. **Run** [TC17, VX19]. **Run-to-Run** [TC17]. **Runs** [MKBN19, MLF+16]. **Rutledge** [Bzi11].

S [Ahm10, Ano10e, Bur10, Oli10a, Pfa12, Sar11]. **Salmaso** [Ano10p]. **Samaniego** [Gru11]. **Sample** [McC12c, SNM10, Wył10]. **Samples** [QAHS14, SHD18, KMM11]. **Sampling** [CBC15, JWG+19, LVB13, Laz11, LQ14, LZ15, LMS15, Nat12, QWKR14, SH14, XWL18, WYJ10, Esp11, Ng10]. **Sandrine** [Ano12l]. **Sara** [Ano12m]. **Sarkar** [Kuh10]. **SAS** [Ano11o, Sau11, Sea11a, Sea12, Ke11b, Gho10a, Ng12, Oli10a, Hec11, Ke11a]. **SAS/IML** [Sea11a, Sea12]. **SAS(R)** [Bzi11, Rut12]. **Satellite** [ZCW19]. **Saunders** [ZLD16]. **Saveliev** [Oli10b]. **Sawitzki** [Boo10b]. **Scalable** [GB18]. **Scale** [EW10, HLP13, HP12, NHQ17, RTA11]. **Scaled** [CS16]. **Scan** [NHB+13, Nag11]. **Scheme** [LQ14, STZW16]. **Schemes** [FNL11, JN16]. **Schinazi** [Ano12i]. **Schlattmann** [Hec10]. **Schmee** [Wlu12]. **Schmid** [Jen11]. **Schreier** [Ke11b]. **Science** [Ahm19b, DNV16, Ano10k, Hor11e]. **Sciences** [Ahm19c, Lip12a, Lip19b, Mye12a, Mag11, Mye12a]. **Scientific** [Hor12b, Ng11]. **Scott** [Che11a]. **Screening** [ACH14, BGMA14, DWD+14, JN16, JN17, LSP13, MSE17, MDS12, QX14, Qu10, SWWR14, WB11, ZHOY13]. **Search** [GH16, Jon13, WB11]. **Season** [NAEK15]. **Seasonal** [AGMRS11, Hor11a]. **Secch** [Ano12f]. **Second** [Ano12g]. **Sectional** [ZZD+14]. **Selected** [Ano11n, Ano11l, Ano11m, Ano12k, Ano12l, Ano12m, Hor12c, Hor12d]. **Selecting** [LCAc13, MSE17]. **Selection** [AGV12, BLK19, Fra19, HLBS19, JN17, LZ14, PJR15, SWMW13, TW13, Wad16, WB11, ZLD16, Lip10a]. **Self** [STZW16]. **Self-Starting** [STZW16]. **Semifoldover** [Edw11]. **Seminars** [Hor11b]. **Semiparametric** [LZW15, SDR15, XKHY18, YXTC14]. **Seneta** [Ano11l]. **Sense** [Hor10b]. **Sensing** [NKCB14, ZCW19]. **Sensitivity** [FK14, LWM13, MDS12]. **Sensitivity-Based** [MDS12]. **Sensor** [JDLH16, PJR15, ZS15]. **Sensory** [Hor11e]. **Sentiment** [Tad13]. **Separation** [BWMG14]. **Sequences** [AHS16, SHG12]. **Sequencing** [WHQ18]. **Sequential**

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